

Notice of References Cited	Application/Control No. 10/733,702	Applicant(s)/Patent Under Reexamination FETCENKO ET AL.	
	Examiner Cam N. Nguyen	Art Unit 1754	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-6,830,725 B2	12-2004	Fetcenko et al.	420/580
	B	US-6,040,087	03-2000	Kawakami, Soichiro	429/218.1
	C	US-6,103,024	08-2000	Sapru et al.	148/403
	D	US-6,329,101	12-2001	Kawakami, Soichiro	429/218.2
	E	US-5,853,919	12-1998	Kohno et al.	429/223
	F	US-6,627,340	09-2003	Ovshinsky et al.	429/20
	G	US-6,491,866	12-2002	Ovshinsky et al.	420/402
	H	US-5,976,276	11-1999	Sapru et al.	148/403
	I	US-6,328,821	12-2001	Ovshinsky et al.	148/420
	J	US-6,207,104	03-2001	Kadir et al.	420/416
	K	US-5,616,432	04-1997	Ovshinsky et al.	429/59
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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	V	
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	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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